
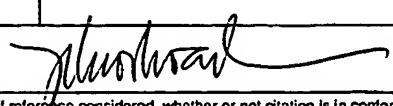


FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-311	SERIAL NO.			
<b>LIST OF DOCUMENTS CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>				APPLICANT F. ARAKAWA				
				FILING DATE December 20, 2001		GROUP		
<b>U.S. PATENT DOCUMENTS</b>								
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)		
PH	AA	5,812,811	09/22/98	Dubey et al			JF503 U.S. PTO 10/022533  12/20/01	
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
<b>FOREIGN PATENT DOCUMENTS</b>								
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						YES	NO	
PH	AL	8-249183	9/27/96	Japan			<input type="checkbox"/>	<input checked="" type="checkbox"/>
	AM						<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>								
PH	AR	MICROPROCESSOR REPORT, Vol. 13, No. 13, October 6, 1999, "Merced Shows Innovative Design", pp. 1, 6-10.						
PH	AS	MICROPROCESSOR REPORT, Vol., 13, No. 16, December 6, 1999, "Compaq Chooses SMT for Alpha", pp. 1, 6-11.						
PH	AT	MICROPROCESSOR REPORT, Vol. 14, Archive.3, March 2000, "NEC Decands Merlot", pp. 14, 15.						
EXAMINER 				DATE CONSIDERED 6/12/05				
<small>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								